Distributed Machine Learning in Blockchain Assisted 5G Fixed Wireless Access Networks

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Message from the Guest Editors

Dear Colleagues,

Recent developments in blockchain technologies, including distributed ledger frameworks, consensus algorithms, intelligent contract engines, development libraries, and interfaces with other systems, are creating new types of services that were previously impossible. Network design and management applications for these emerging technologies are challenging tasks. This Special Issue aims to solicit state-of-the-art research on the secure blockchain-based computing framework of DML in a 5G network. We invite researchers to submit their original research about the framework development, deployments, opportunities, and problems using secure blockchain-based DML in a 5G network.

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Special Issue

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Message from the Editor-in-Chief

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